

# Agnäs Graner

## List of Publications by Year in descending order

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105  
papers

2,500  
citations

186265

28  
h-index

243625

44  
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105  
all docs

105  
docs citations

105  
times ranked

2023  
citing authors

#	ARTICLE	IF	CITATIONS
1	Low-temperature deposition of self-cleaning anatase TiO <sub>2</sub> coatings on polymer glazing via sequential continuous and pulsed PECVD. <i>Surface and Coatings Technology</i> , 2022, 436, 128256.	4.8	3
2	Hybrid approaches coupling sol-gel and plasma for the deposition of oxide-based nanocomposite thin films: a review. <i>SN Applied Sciences</i> , 2021, 3, 1.	2.9	6
3	Unveiling a critical thickness in photocatalytic TiO <sub>2</sub> thin films grown by plasma-enhanced chemical vapor deposition using real time in situ spectroscopic ellipsometry. <i>Journal Physics D: Applied Physics</i> , 2021, 54, 445303.	2.8	4
4	TiO <sub>2</sub> -SiO <sub>2</sub> nanocomposite thin films deposited by direct liquid injection of colloidal solution in an O <sub>2</sub> /HMDSO low-pressure plasma. <i>Journal Physics D: Applied Physics</i> , 2021, 54, 085206.	2.8	12
5	Unravelling local environments in mixed TiO <sub>2</sub> -SiO <sub>2</sub> thin films by XPS and ab initio calculations. <i>Applied Surface Science</i> , 2020, 510, 145056.	6.1	23
6	Modification of the optical properties and nano-crystallinity of anatase TiO <sub>2</sub> nanoparticles thin film using low pressure O <sub>2</sub> plasma treatment. <i>Thin Solid Films</i> , 2020, 709, 138212.	1.8	9
7	Plasma deposition—Impact of ions in plasma enhanced chemical vapor deposition, plasma enhanced atomic layer deposition, and applications to area selective deposition. <i>Journal of Vacuum Science and Technology A: Vacuum, Surfaces and Films</i> , 2020, 38, .	2.1	32
8	Anatase TiO <sub>2</sub> deposited at low temperature by pulsing an electron cyclotron wave resonance plasma source. <i>Scientific Reports</i> , 2020, 10, 21952.	3.3	3
9	TEM analysis of photocatalytic TiO <sub>2</sub> thin films deposited on polymer substrates by low-temperature ICP-PECVD. <i>Applied Surface Science</i> , 2019, 491, 116-122.	6.1	20
10	Ion impingement effect on the structure and optical properties of Ti <sub>x</sub> Si <sub>1-x</sub> O <sub>2</sub> films deposited by ICP-PECVD. <i>Plasma Processes and Polymers</i> , 2019, 16, 1900034.	3.0	3
11	Nanostructure and photocatalytic properties of TiO <sub>2</sub> films deposited at low temperature by pulsed PECVD. <i>Applied Surface Science</i> , 2019, 466, 63-69.	6.1	27
12	Microstructure and Photocatalytic Properties of TiO <sub>2</sub> -Reduced Graphene Oxide Nanocomposites Prepared by Solvothermal Method. <i>Journal of Electronic Materials</i> , 2018, 47, 7372-7379.	2.2	8
13	The Effect of Plasma Gas Composition on the Nanostructures and Optical Properties of TiO <sub>2</sub> Films Prepared by Helicon-PECVD. <i>Nano</i> , 2018, 13, 1850124.	1.0	1
14	Annealing and biasing effects on the structural and optical properties of PECVD-grown TiO <sub>2</sub> films from TTIP/O <sub>2</sub> plasma. <i>Journal of Materials Science: Materials in Electronics</i> , 2018, 29, 13254-13264.	2.2	3
15	Tailoring the chemistry and the nano-architecture of organic thin films using cold plasma processes. <i>Plasma Processes and Polymers</i> , 2017, 14, 1700042.	3.0	6
16	Structural and optical properties of RF-biased PECVD TiO <sub>2</sub> thin films deposited in an O <sub>2</sub> /TTIP helicon reactor. <i>Vacuum</i> , 2016, 131, 231-239.	3.5	11
17	Effect of growth interruptions on TiO <sub>2</sub> films deposited by plasma enhanced chemical vapour deposition. <i>Materials Chemistry and Physics</i> , 2016, 182, 409-417.	4.0	15
18	Structural and Optical Properties of PECVD TiO <sub>2</sub> -SiO <sub>2</sub> Mixed Oxide Films for Optical Applications. <i>Plasma Processes and Polymers</i> , 2016, 13, 918-928.	3.0	17

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19	Creating nanoporosity in silver nanocolumns by direct exposure to radio-frequency air plasma. <i>Nanoscale</i> , 2016, 8, 141-148.	5.6	34
20	Effect of ion bombardment on the structural and optical properties of TiO <sub>2</sub> thin films deposited from oxygen/titanium tetraisopropoxide inductively coupled plasma. <i>Thin Solid Films</i> , 2015, 589, 783-791.	1.8	21
21	Titanium carbide/carbon nanocomposite hard coatings: A comparative study between various chemical analysis tools. <i>Surface and Coatings Technology</i> , 2014, 256, 41-46.	4.8	12
22	H atom surface loss kinetics in pulsed inductively coupled plasmas. <i>Plasma Sources Science and Technology</i> , 2013, 22, 055004.	3.1	6
23	In situ spectroscopic ellipsometry study of TiO <sub>2</sub> films deposited by plasma enhanced chemical vapour deposition. <i>Applied Surface Science</i> , 2013, 283, 234-239.	6.1	34
24	X-ray reflectometry study of diamond-like carbon films prepared by plasma enhanced chemical vapor deposition in a low pressure inductively coupled plasma. <i>Thin Solid Films</i> , 2013, 537, 102-107.	1.8	0
25	Spectroscopic ellipsometry analysis of TiO <sub>2</sub> films deposited by plasma enhanced chemical vapor deposition in oxygen/titanium tetraisopropoxide plasma. <i>Thin Solid Films</i> , 2012, 522, 366-371.	1.8	23
26	Structural characterization and electrochemical behavior of titanium carbon thin films. <i>Surface and Coatings Technology</i> , 2012, 211, 192-195.	4.8	7
27	The influence of Ni content on the characteristics of Ni thin films. <i>Surface and Coatings Technology</i> , 2012, 211, 188-191.	4.8	7
28	Fabrication of a nickel nanowire mesh electrode suspended on polymer substrate. <i>Nanotechnology</i> , 2012, 23, 275603.	2.6	10
29	Shape control of nickel nanostructures incorporated in amorphous carbon films: From globular nanoparticles toward aligned nanowires. <i>Journal of Applied Physics</i> , 2012, 111, .	2.5	24
30	Highly ordered ultralong magnetic nanowires wrapped in stacked graphene layers. <i>Beilstein Journal of Nanotechnology</i> , 2012, 3, 846-851.	2.8	8
31	Hierarchical carbon nanostructure design: ultra-long carbon nanofibers decorated with carbon nanotubes. <i>Nanotechnology</i> , 2011, 22, 435302.	2.6	23
32	Synthesis of nickel-filled carbon nanotubes at 350 °C. <i>Carbon</i> , 2011, 49, 4595-4598.	10.3	25
33	XPS study of the surface composition modification of nc-TiC/C nanocomposite films under in situ argon ion bombardment. <i>Thin Solid Films</i> , 2011, 519, 3982-3985.	1.8	59
34	Preparation and modification of carbon nanotubes electrodes by cold plasmas processes toward the preparation of amperometric biosensors. <i>Electrochimica Acta</i> , 2010, 55, 7916-7922.	5.2	17
35	Microstructure and composition of TiC/a-C:H nanocomposite thin films deposited by a hybrid IPVD/PECVD process. <i>Surface and Coatings Technology</i> , 2010, 204, 1880-1883.	4.8	35
36	Response to "Comment on "Carbon nanowalls as material for electrochemical transducers" [Appl. Phys. Lett. 96 126102 (2010)]. <i>Applied Physics Letters</i> , 2010, 96, 126103.	3.3	2

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37	Titanium carbide/carbon composite nanofibers prepared by a plasma process. <i>Nanotechnology</i> , 2010, 21, 435603.	2.6	13
38	Carbon nanowalls as material for electrochemical transducers. <i>Applied Physics Letters</i> , 2009, 95, .	3.3	47
39	Ionized Physical Vapour Deposition combined with PECVD, for synthesis of carbon-metal nanocomposite thin films. <i>Solid State Sciences</i> , 2009, 11, 1824-1827.	3.2	14
40	Influence of Ion Bombardment and Annealing on the Structural and Optical Properties of TiO <sub>2</sub> Thin Films Deposited in Inductively Coupled TTIP/O <sub>2</sub> Plasma. <i>Plasma Processes and Polymers</i> , 2009, 6, S741.	3.0	8
41	Early stages of the carbon nanotube growth by low pressure CVD and PE-CVD. <i>Diamond and Related Materials</i> , 2009, 18, 61-65.	3.9	20
42	Integration of a carbon nanotube based electrode in silicon microtechnology to fabricate electrochemical transducers. <i>Nanotechnology</i> , 2008, 19, 435502.	2.6	8
43	Integrated optics based on plasma processed dielectric materials. <i>Proceedings of SPIE</i> , 2008, , .	0.8	0
44	Influence of ion bombardment on structural and electrical properties of SiO <sub>2</sub> thin films deposited from O <sub>2</sub> /HMDSO inductively coupled plasmas under continuous wave and pulsed modes. <i>EPJ Applied Physics</i> , 2008, 42, 3-8.	0.7	4
45	Impact of the etching gas on vertically oriented single wall and few walled carbon nanotubes by plasma enhanced chemical vapor deposition. <i>Journal of Applied Physics</i> , 2007, 101, 054317.	2.5	25
46	Investigation of O-atom kinetics in O <sub>2</sub> , CO <sub>2</sub> , H <sub>2</sub> O and O <sub>2</sub> /HMDSO low pressure radiofrequency pulsed plasmas by time-resolved optical emission spectroscopy. <i>Plasma Sources Science and Technology</i> , 2007, 16, 597-605.	3.1	28
47	Single- and Few-Walled Carbon Nanotubes Grown at Temperatures as Low as 450 Å°C: Electrical and Field Emission Characterization. <i>Journal of Nanoscience and Nanotechnology</i> , 2007, 7, 3350-3353.	0.9	4
48	ERDA and Structural Characterization of Oriented Multiwalled Carbon Nanotubes. <i>Journal of Physical Chemistry C</i> , 2007, 111, 10353-10358.	3.1	3
49	Impact of the Cu-based substrates and catalyst deposition techniques on carbon nanotube growth at low temperature by PECVD. <i>Microelectronic Engineering</i> , 2007, 84, 2501-2505.	2.4	20
50	First developments for photonics integrated on plasma-polymer-HMDSO: Single-mode TE <sub>00</sub> -TM <sub>00</sub> straight waveguides. <i>Optical Materials</i> , 2007, 30, 657-661.	3.6	8
51	Growth kinetics of low temperature single-wall and few walled carbon nanotubes grown by plasma enhanced chemical vapor deposition. <i>Physica E: Low-Dimensional Systems and Nanostructures</i> , 2007, 37, 34-39.	2.7	18
52	Comparative Study of Films Deposited from HMDSO/O <sub>2</sub> in Continuous Wave and Pulsed rf Discharges. <i>Plasma Processes and Polymers</i> , 2007, 4, S287-S293.	3.0	13
53	Characterization of carbon nanotubes and carbon nitride nanofibres synthesized by PECVD. <i>EPJ Applied Physics</i> , 2006, 34, 157-163.	0.7	9
54	Growth and Modification of Organosilicon Films in PECVD and Remote Afterglow Reactors. <i>Plasma Processes and Polymers</i> , 2006, 3, 100-109.	3.0	57

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55	Mechanisms Involved in the Conversion of ppHMDSO Films into SiO <sub>2</sub> -Like by Oxygen Plasma Treatment. Plasma Processes and Polymers, 2006, 3, 365-373.	3.0	20
56	Limits of the PECVD process for single wall carbon nanotubes growth. Chemical Physics Letters, 2006, 421, 242-245.	2.6	28
57	Low temperature plasma carbon nanotubes growth on patterned catalyst. Microelectronic Engineering, 2006, 83, 2427-2431.	2.4	6
58	Comparison of structure and mechanical properties of SiO <sub>2</sub> -like films deposited in O <sub>2</sub> /HMDSO pulsed and continuous plasmas. Surface and Coatings Technology, 2006, 200, 6517-6521.	4.8	25
59	Influence of plasma pulsing on the deposition kinetics and film structure in low pressure oxygen/hexamethyldisiloxane radiofrequency plasmas. Thin Solid Films, 2006, 514, 45-51.	1.8	26
60	Study of magnetic field influence on charged species in a low pressure helicon reactor. European Physical Journal D, 2006, 56, B1091-B1096.	0.4	0
61	Photonics integrated circuits on plasma-polymer-HMDSO: Single-mode TE <sub>00</sub> -TM <sub>00</sub> straight waveguides, S-Bends, Y-Junctions and Mach-Zehnder Interferometers. , 2006, , .		0
62	Versatile SOG/SU-8/fluorinated SU-8 rib optical waveguides as microsystems: single-mode TE <sub>00</sub> -TM <sub>00</sub> straight waveguides, S-Bends, Y-Junctions, Mach-Zehnder interferometers. , 2005, 5956, 233.		0
63	Single chamber PVD/PECVD process for in situ control of the catalyst activity on carbon nanotubes growth. Surface and Coatings Technology, 2005, 200, 1101-1105.	4.8	30
64	XPS and NEXAFS characterisation of plasma deposited vertically aligned N-doped MWCNT. Diamond and Related Materials, 2005, 14, 891-895.	3.9	53
65	The combined study of the organosilicon films by RBS, ERDA and AFM analytical methods obtained from PECVD and PACVD. Surface Science, 2004, 566-568, 1143-1146.	1.9	7
66	Growth mechanisms of carbon nanotubes converted from diamond-like carbon films. Chemical Physics Letters, 2004, 397, 516-519.	2.6	3
67	Room temperature synthesis of carbon nanofibers containing nitrogen by plasma-enhanced chemical vapor deposition. Applied Physics Letters, 2004, 85, 1244-1246.	3.3	56
68	Optical emission spectra of TEOS and HMDSO derived plasmas used for thin film deposition. Plasma Sources Science and Technology, 2003, 12, 89-96.	3.1	66
69	Electrical properties of low-dielectric-constant films prepared by PECVD in O <sub>2</sub> /CH <sub>4</sub> /HMDSO. Materials Science in Semiconductor Processing, 2002, 5, 279-284.	4.0	22
70	Analysis of Low-k Organosilicon and Low-Density Silica Films Deposited in HMDSO Plasmas. Plasmas and Polymers, 2002, 7, 341-352.	1.5	29
71	Carbon nanotubes and nanostructures grown from diamond-like carbon and polyethylene. Applied Physics A: Materials Science and Processing, 2001, 73, 765-768.	2.3	27
72	Structure and properties of silicon oxide films deposited in a dual microwave-rf plasma reactor. Thin Solid Films, 2001, 384, 230-235.	1.8	25

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73	Mass spectrometric investigation of the positive ions formed in low-pressure oxygen/tetraethoxysilane and argon/tetraethoxysilane plasmas. <i>Journal of Applied Physics</i> , 2001, 89, 5227-5229.	2.5	5
74	A comparative study of oxygen/organosilicon plasmas and thin SiO <sub>x</sub> CyHz films deposited in a helicon reactor. <i>Thin Solid Films</i> , 2000, 359, 188-196.	1.8	124
75	Analysis of Tiâ€“Siâ€“N diffusion barrier films obtained by r.f. magnetron sputtering. <i>Microelectronic Engineering</i> , 2000, 50, 509-513.	2.4	14
76	Measurements of rf bias effect in a dual electron cyclotron resonance-rf methane plasma using the Langmuir probe method. <i>Journal of Vacuum Science and Technology A: Vacuum, Surfaces and Films</i> , 2000, 18, 497-502.	2.1	9
77	Estimation of the TEOS dissociation coefficient by electron impact. <i>Journal of Vacuum Science and Technology A: Vacuum, Surfaces and Films</i> , 2000, 18, 2728-2732.	2.1	6
78	Optical spectroscopic analyses of OH incorporation into SiO[sub 2] films deposited from O[sub 2]/tetraethoxysilane plasmas. <i>Journal of Vacuum Science and Technology A: Vacuum, Surfaces and Films</i> , 2000, 18, 2452.	2.1	47
79	Study of oxygen/tetraethoxysilane plasmas in a helicon reactor using optical emission spectroscopy and mass spectrometry. <i>Plasma Sources Science and Technology</i> , 2000, 9, 331-339.	3.1	24
80	Inorganic to organic crossover in thin films deposited from O <sub>2</sub> /TEOS plasmas. <i>Journal of Non-Crystalline Solids</i> , 2000, 272, 163-173.	3.1	64
81	In situ deposition and etching process of a-C:H:N films in a dual electron cyclotron resonanceâ€“radio frequency plasma. <i>Diamond and Related Materials</i> , 2000, 9, 573-576.	3.9	22
82	Experimental investigation of the respective roles of oxygen atoms and electrons in the deposition of SiO <sub>2</sub> in O <sub>2</sub> /TEOS helicon plasmas. <i>Journal of Vacuum Science and Technology A: Vacuum, Surfaces and Films</i> , 1999, 17, 2470-2474.	2.1	20
83	Growth, microstructure and electronic properties of amorphous carbon nitride films investigated by plasma diagnostics. <i>Journal of Applied Physics</i> , 1999, 86, 4668-4676.	2.5	21
84	Experimental study of Tiâ€“Siâ€“N films obtained by radio frequency magnetron sputtering. <i>Surface and Coatings Technology</i> , 1999, 116-119, 922-926.	4.8	10
85	Silicon dioxide deposition in a microwave plasma reactor. <i>Surface and Coatings Technology</i> , 1999, 116-119, 868-873.	4.8	52
86	Chemical etching of thin SiO <sub>x</sub> CyHz films by post-deposition exposure to oxygen plasma. <i>Applied Surface Science</i> , 1999, 138-139, 57-61.	6.1	19
87	Study of oxygen/TEOS plasmas and thin SiO <sub>x</sub> films obtained in an helicon diffusion reactor. <i>Surface and Coatings Technology</i> , 1998, 98, 1578-1583.	4.8	27
88	Modelling of low-pressure surface wave discharges in flowing oxygen: I. Electrical properties and species concentrations. <i>Plasma Sources Science and Technology</i> , 1998, 7, 524-536.	3.1	47
89	Diagnostics in helicon plasmas for deposition. <i>Plasma Sources Science and Technology</i> , 1997, 6, 147-156.	3.1	92
90	In situ ellipsometry and infrared analysis of PECVD SiO <sub>2</sub> films deposited in an O <sub>2</sub> /TEOS helicon reactor. <i>Journal of Non-Crystalline Solids</i> , 1997, 216, 48-54.	3.1	31

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91	Direct observation of water incorporation in PECVD SiO <sub>2</sub> films by UV-Visible ellipsometry. Thin Solid Films, 1997, 311, 212-217.	1.8	17
92	Polymer treatment in the flowing afterglow of an oxygen microwave discharge: Active species profile concentrations and kinetics of the functionalization. Plasma Chemistry and Plasma Processing, 1995, 15, 173-198.	2.4	55
93	Microwave discharge in H <sub>2</sub> : influence of H-atom density on the power balance. Journal Physics D: Applied Physics, 1994, 27, 1412-1422.	2.8	83
94	Validity of actinometry to monitor oxygen atom concentration in microwave discharges created by surface wave in O <sub>2</sub> -N <sub>2</sub> mixtures. Journal of Applied Physics, 1994, 75, 104-114.	2.5	80
95	Surface Wave Plasmas in O <sub>2</sub> -N <sub>2</sub> Mixtures as Active Species Sources for Surface Treatments. NATO ASI Series Series B: Physics, 1993, , 491-501.	0.2	6
96	Surface treatment of polypropylene by oxygen microwave discharge. Materials Science & Engineering A: Structural Materials: Properties, Microstructure and Processing, 1991, 139, 103-109.	5.6	34
97	Action of a static magnetic field on an argon discharge produced by a traveling wave. Journal of Applied Physics, 1989, 65, 1465-1478.	2.5	28
98	Characterisation of a low-pressure oxygen discharge created by surface waves. Journal Physics D: Applied Physics, 1989, 22, 1487-1496.	2.8	57
99	Microwave plasma in argon produced by a surface wave: study of the effect of pressure on the optical emission and the potentials for analysis of gaseous samples. Spectrochimica Acta, Part B: Atomic Spectroscopy, 1988, 43, 963-970.	2.9	14
100	Low-Pressure Argon Discharge Sustained by a Wave with an External Applied Magnetic Field. Europhysics Letters, 1988, 6, 413-418.	2.0	7
101	Production of argon metastable atoms in high pressure (20-300 Torr) microwave discharges. Revue De Physique Appliquée, 1988, 23, 1749-1754.	0.4	7
102	Microwave discharges produced by surface waves in argon gas. Journal Physics D: Applied Physics, 1987, 20, 197-203.	2.8	82
103	Wave propagation and diagnostics in argon surface-wave discharges up to 100 Torr. Journal Physics D: Applied Physics, 1987, 20, 204-209.	2.8	67
104	Influence of the excitation frequency on surface wave argon discharges: Study of the light emission. Journal of Applied Physics, 1987, 61, 1740-1746.	2.5	48
105	Argon surface wave discharges at medium pressure. Experiments and discussion on the energy balance. Revue De Physique Appliquée, 1987, 22, 999-1006.	0.4	9